


<b>Search Notes</b> 	<b>Application/Control No.</b> 10682540	<b>Applicant(s)/Patent Under Reexamination</b> KONNO, TAKESHI
	<b>Examiner</b> Fletcher III, William P	<b>Art Unit</b> 1762

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search: no dbl pat rej required. EAST search, including text-delimited search of 427/8, 458, 470, 471, 160, 412.1, 419-419.3, and 419.5: strategy attached. Google Scholar search: results attached.	04/04/2007	/WPF/
EAST: strategy attached.	07/30/2007	/WPF/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
427	8, 470, 160, 177, 419.2, 419.3, 419.5	07/30/2007	/WPF/